

RS-232 TRANSCEIVER WITH SPLIT SUPPLY PIN FOR LOGIC SIDE

Check for Samples: MAX3386E

FEATURES

- V_L Pin for Compatibility With Mixed-Voltage Systems Down to 2.5 V on Logic Side
- Enhanced ESD Protection on RIN Inputs and DOUT Outputs
 - ±15-kV Human-Body Model
 - ±15-kV IEC 61000-4-2, Air-Gap Discharge
 - ±8-kV IEC 61000-4-2, Contact Discharge
- Low 300-µA Supply Current
- Specified 250-kbps Data Rate
- 1-µA Low-Power Shutdown
- Meets EIA/TIA-232 Specifications Down to 3 V

APPLICATIONS

- Hand-Held Equipment
- PDAs
- Cell Phones
- Battery-Powered Equipment
- Data Cables

DESCRIPTION/ORDERING INFORMATION

The MAX3386E is a three-driver and two-receiver RS-232 interface device, with split supply pins for mixed-signal operations. All RS-232 inputs and outputs are protected to ± 15 kV using the IEC 61000-4-2 Air-Gap Discharge method, ± 8 kV using the IEC 61000-4-2 Contact Discharge method, and ± 15 kV using the Human-Body Model.

The charge pump requires only four small 0.1-µF capacitors for operation from a 3.3-V supply. The MAX3386E is capable of running at data rates up to 250 kbps, while maintaining RS-232-compliant output levels.

The MAX3386E has a unique V_L pin that allows operation in mixed-logic voltage systems. Both driver in (DIN) and receiver out (ROUT) logic levels are pin programmable through the V_L pin. The MAX3386E is available in a space-saving thin shrink small-outline package (TSSOP).

T _A	PACKAGE ⁽¹⁾ ⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING			
0°C to 70°C	TSSOP – PW	MAX3386ECPWR	MP386EC			
0°C to 70°C	SOIC – DW	MAX3386ECDW	MAX3386EC			
40%0 12 05%0	TSSOP – PW	MAX3386EIPWR	MP386EI			
–40°C to 85°C	SOIC - DW	MAX3386EIDW	MAX3386EI			

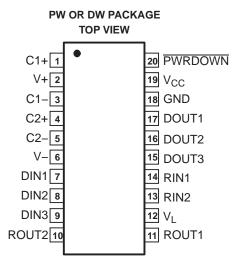
ORDERING INFORMATION

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



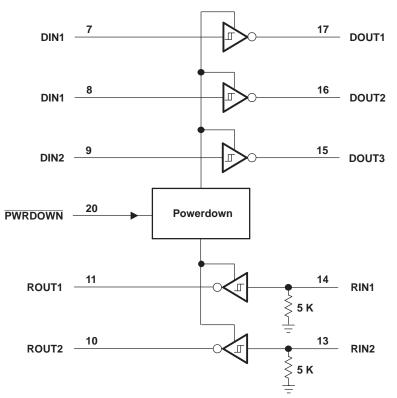
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PWRDWN	DRIVER OUTPUTS	RECEIVER OUTPUTS	CHARGE PUMP						
L	High-Z	High-Z	Inactive						
Н	Active	Active	Active						

Table 1. TRUTH TABLE (SHUTDOWN FUNCTION)



FUNCTIONAL BLOCK DIAGRAM

TERMINAL FUNCTIONS

TERMINAL		DESCRIPTION	
NAME	NO.	DESCRIPTION	
C1+	1	Positive terminal of the voltage-doubler charge-pump capacitor	
V+	2	5.5-V supply generated by the charge pump	
C1–	3	Negative terminal of the voltage-doubler charge-pump capacitor	
C2+	4	Positive terminal of the inverting charge-pump capacitor	
C2–	5	Negative terminal of the inverting charge-pump capacitor	
V–	6	-5.5-V supply generated by the charge pump	
DIN1 DIN2 DIN3	7 8 9	Driver inputs	
ROUT2 ROUT1	10 11	Receiver outputs. Swing between 0 and V_L .	
VL	12	Logic-level supply. All CMOS inputs and outputs are referenced to this supply.	
RIN2 RIN1	13 14	RS-232 receiver inputs	
DOUT3 DOUT2 DOUT1	15 16 17	RS-232 driver outputs	
GND	18	Ground	



SLLS659B – MAY 2006 – REVISED MARCH 2011

TERMINAL FUNCTIONS (continued)

TERMIN	NAL	DESCRIPTION
NAME	NO.	DESCRIPTION
V _{CC}	19	3-V to 5.5-V supply voltage
PWRDWN	20	Powerdown input L = Powerdown H = Normal operation

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
	V _{CC} to GND		-0.3	6	V
	V _L to GND		-0.3	V _{CC} + 0.3	V
	V+ to GND		-0.3	7	V
	V– to GND		0.3	-7	V
	V+ + V- ⁽²⁾			13	V
V		DIN, PWRDWN to GND	-0.3	6	v
VI	Input voltage	RIN to GND		6 V _{CC} + 0.3 7 -7 13	V
	O data data la con	DOUT to GND		±13.2	v
Vo	Output voltage	ROUT	-0.3	V _L + 0.3	V
	Short-circuit duration DOUT to GND			$\begin{array}{c} & & & \\ & V_{CC} + 0.3 \\ & & 7 \\ & & 7 \\ & & & 7 \\ & & & & 7 \\ & & & &$	
	Continuous power dissipation	T _A = 70°C, 20-pin TSSOP (derate 7 mW/°C above 70°C)		559	mW
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature range		-65	150	°C
	Lead temperature (soldering, 10 s)			300	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(2) V+ and V- can have maximum magnitudes of 7 V, but their absolute difference cannot exceed 13 V.

Recommended Operating Conditions

				MIN	MAX	UNIT
V_{CC}	Supply voltage			3	5.5	V
VL	Supply voltage			2.25	V _{CC}	V
	Innut logic threshold low	V _L = 2.3 V V _L = 5.5 V		0.8	V	
	Input logic threshold low	DIN, PWRDWN	$V_L = 2.3 V$		0.6	v
			V _L = 5.5 V	2.4		
	Input logic threshold high	DIN, PWRDWN	$V_L = 3 V$	2.0		V
			$V_{L} = 2.7 V$	1.4	5.5 V _{CC} 0.8	
			MAX3386ECPWR	0	3 5.5 2.25 V _{CC} 0.8 0.6 2.4 2.0 1.4 0 -40 85	°C
	Operating temperature		MAX3386EIPWR	-40	85	C
	Receiver input voltage			-25	25	V

Electrical Characteristics

over operating free-air temperature range, $V_{CC} = V_L = 3 V$ to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%) (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
DC Characteristics (V _{CC} = 3.	teristics ($V_{CC} = 3.3 \text{ V or } 5 \text{ V}, T_A = 25^{\circ}\text{C}$)				
Powerdown supply current	$\overline{PWRDWN} = GND$, All inputs at V _{CC} or GND		1	10	μA

(1) Typical values are at $V_{CC} = V_L = 3.3 \text{ V}$, $T_A = 25^{\circ}C$.

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SLLS659B-MAY 2006-REVISED MARCH 2011

Electrical Characteristics (continued)

over operating free-air temperature range, $V_{CC} = V_L = 3 \text{ V}$ to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%) (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
Supply current	$\overline{PWRDWN} = V_{CC}$, No load		0.3	1	mA

ESD Protection

PARAMETER	TEST CONDITIONS	TYP	UNIT
	Human-Body Model	±15	
RIN, DOUT	IEC 61000-4-2 Air-Gap Discharge	±15	kV
	IEC 61000-4-2 Contact Discharge	±8	

RECEIVER SECTION

Electrical Characteristics

over operating free-air temperature range, $V_{CC} = V_L = 3 V$ to 5.5 V, C1–C4 = 0.1 μ F (tested at 3.3 V ± 10%), C1 = 0.047 μ F, C2–C4 = 0.33 μ F (tested at 5 V ± 10%), T_A = T_{MIN} to T_{MAX} (unless otherwise noted)

	PARAMETER	TEST C	ONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
I _{off}	Output leakage current	ROUT, receivers disab	led		±0.05	±10	μA
V _{OL}	Output voltage low	I _{OUT} = 1.6 mA				0.4	V
V _{OH}	Output voltage high	$I_{OUT} = -1 \text{ mA}$		$V_{L} - 0.6$	$V_L - 0.1$		V
V	Incut thread and low	T 25°C	$V_L = 5 V$	0.8	1.2	1.5	V
V _{IT–}	Input threshold low	$T_A = 25^{\circ}C$	$V_{L} = 3.3 V$	0.6	1.5		V
V	Incut thread and high	T 25°C	$V_L = 5 V$		1.8	2.4	V
V _{IT+}	Input threshold high	$T_A = 25^{\circ}C$	$V_{L} = 3.3 V$		1.5	2.4	v
V _{hys}	Input hysteresis				0.5		V
	Input resistance	$T_A = 25^{\circ}C$		3	5	7	kΩ

(1) Typical values are at V_{CC} = V_L = 3.3 V, T_A = 25°C

Switching Characteristics

over operating free-air temperature range, $V_{CC} = V_L = 3 \text{ V}$ to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), T_A = T_{MIN} to T_{MAX} (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	TYP ⁽¹⁾	UNIT
t _{PHL}	Receiver propagation dolog	People or input to receiver output $C = 150 \text{ pc}$	0.15	
t _{PLH}	Receiver propagation delay	Receiver input to receiver output, $C_L = 150 \text{ pF}$		μs
t _{PHL} – t _{PLH}	Receiver skew		50	ns
t _{en}	Receiver output enable time	From PWRDWN	200	ns
t _{dis}	Receiver output disable time	From PWRDWN	200	ns

(1) Typical values are at V_{CC} = V_L = 3.3 V, T_A = 25°C.

SLLS659B-MAY 2006-REVISED MARCH 2011

DRIVER SECTION

Electrical Characteristics

over operating free-air temperature range, $V_{CC} = V_L = 3 V$ to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), T_A = T_{MIN} to T_{MAX} (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{OH}	Output voltage swing	All driver outputs loaded with 3 $k\Omega$ to ground	±5	±5.4		V
r _o	Output resistance	$V_{CC} = V + = V - = 0$, Driver output = ±2 V	300	10M		Ω
I _{OS}	Output short-circuit current	$V_{T_OUT} = 0$			±60	mA
I _{OZ}	Output leakage current	$V_{T_OUT} = \pm 12$ V, Driver disabled, $V_{CC} = 0$ or 3 V to 5.5 V			±25	μA
	Driver input hysteresis				0.5	V
	Input leakage current	DIN, PWRDWN		±0.01	±1	μA

(1) Typical values are at $V_{CC} = V_L = 3.3 \text{ V}$, $T_A = 25^{\circ}C$

Timing Requirements

over operating free-air temperature range, $V_{CC} = V_L = 3 V$ to 5.5 V, C1–C4 = 0.1 µF (tested at 3.3 V ± 10%), C1 = 0.047 µF, C2–C4 = 0.33 µF (tested at 5 V ± 10%), T_A = T_{MIN} to T_{MAX} (unless otherwise noted)

	PARAMETER			MIN	TYP ⁽¹⁾	MAX	UNIT
	Maximum data rate	$R_L = 3 \text{ k}\Omega, C_L = 1000 \text{ pF}, O$	ne driver switching	250			kbps
	Time-to-exit powerdown	V _{T_OUT} > 3.7 V			100		μs
t _{PHL} – t _{PLH}	Driver skew ⁽²⁾				100		ns
		$V_{CC} = 3.3 V,$ $T_A = 25^{\circ}C,$	$C_{L} = 150 \text{ pF} \text{ to } 1000 \text{ pF}$	6		30	
	slew rate $R_L = 3 k\Omega$ Measured	$ \begin{array}{l} T_A = 25^\circ C, \\ R_L = 3 \ k\Omega \ to \ 7 \ k\Omega, \\ \mbox{Measured from 3 V} \\ to \ -3 \ V \ or \ -3 \ V \ to \ 3 \ V \end{array} $	C _L = 150 pF to 2500 pF	4		30	V/µs

(1) Typical values are at $V_{CC} = V_L = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$. (2) Driver skew is measured at the driver zero crosspoint.

ESD Protection

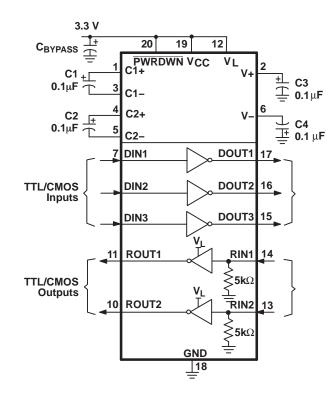
PARAMETER	TEST CONDITIONS	TYP	UNIT
	Human-Body Model	±15	
RIN, DOUT	IEC 61000-4-2 Air-Gap Discharge	±15	kV
	IEC 61000-4-2 Contact Discharge	±8	

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APPLICATION INFORMATION



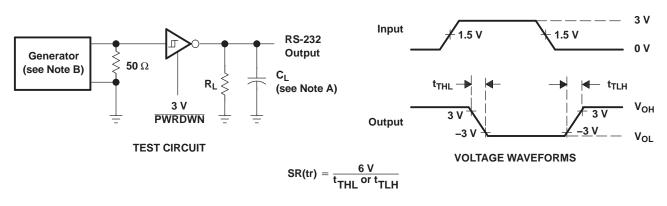
MAX3386E

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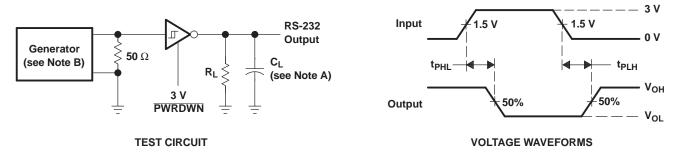
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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. CL includes probe and jig capacitance.
 - B. The pulse generator has the following characteristics: PRR = 250 kbit/s, Z_O = 50 Ω , 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

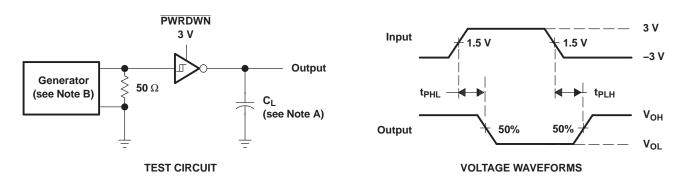




NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s, $Z_0 = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns. $t_f \le 10$ ns.

Figure 2. Driver Pulse Skew



NOTES: A. C_L includes probe and jig capacitance. B. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

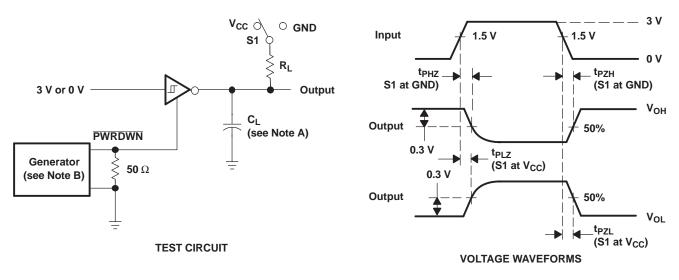
Figure 3. Receiver Propagation Delay Times



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

B. The pulse generator has the following characteristics: $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

Figure 4. Receiver Enable and Disable Times

Product Folder Link(s): MAX3386E

REVISION HISTORY

CI	hanges from Revision A (November 2008) to Revision B	Page
•	Changed V _L Pin for Compatibility With Mixed-Voltage Systems Down to 2.5 V (originally 1.8 V) on the Logic Side	1
•	Changed V _L Supply MIN value from 1.65 V to 2.25 V.	3
•	Deleted V _L = 1.65V parameter from Input logic threshold low.	3
•	Deleted V _L = 1.95V parameter from Input logic threshold high.	3

10

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
	(1)		j		,	(2)	(6)	(3)		(4,3)	
MAX3386ECDWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3386EC	Samples
MAX3386ECPW	NRND	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP386EC	
MAX3386ECPWR	NRND	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MP386EC	
MAX3386EIDW	NRND	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3386EI	
MAX3386EIDWR	NRND	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX3386EI	
MAX3386EIPW	NRND	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP386EI	
MAX3386EIPWR	NRND	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MP386EI	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

21-Mar-2024

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Texas

*All dimensions are nominal

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3386ECDWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
MAX3386ECPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
MAX3386EIDWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
MAX3386EIPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1



PACKAGE MATERIALS INFORMATION

15-Dec-2023



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3386ECDWR	SOIC	DW	20	2000	367.0	367.0	45.0
MAX3386ECPWR	TSSOP	PW	20	2000	356.0	356.0	35.0
MAX3386EIDWR	SOIC	DW	20	2000	367.0	367.0	45.0
MAX3386EIPWR	TSSOP	PW	20	2000	356.0	356.0	35.0

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15-Dec-2023

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
MAX3386ECPW	PW	TSSOP	20	70	530	10.2	3600	3.5
MAX3386EIDW	DW	SOIC	20	25	507	12.83	5080	6.6
MAX3386EIPW	PW	TSSOP	20	70	530	10.2	3600	3.5

PW0020A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0020A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0020A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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